



Dual Enhancement Mode Field Effect Transistor (N and P Channel)

PRODUCT SUMMARY (N-Channel)		
V _{DSS}	I _D	R _{D(S)ON} (mΩ) Max
30V	7A	25 @ V _{GS} = 10V
		40 @ V _{GS} = 4.5V

PRODUCT SUMMARY (P-Channel)		
V _{DSS}	I _D	R _{D(S)ON} (mΩ) Max
-30V	-5.3A	45 @ V _{GS} = -10V
		60 @ V _{GS} = -4.5V

ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)

Parameter	Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage	V _{DS}	30	-30	V	
Gate-Source Voltage	V _{GS}	±20	±20	V	
Drain Current-Continuous ^a @ T _A	25°C	I _D	7	-5.3	A
	70°C		6	-4.2	A
-Pulsed ^b	I _{DM}		29	-21	A
Drain-Source Diode Forward Current ^a	I _S	1.7	-1.7	A	
Maximum Power Dissipation ^a	T _A =25°C	P _D	2	W	
	T _A =70°C		1.44		
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150		°C	

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient ^a	R _{θJA}	62.5	°C/W
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N-Channel ELECTRICAL CHARACTERISTICS (TA = 25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250µA	30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 24V, V _{GS} = 0V		1		µA
Gate-Body Leakage	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
ON CHARACTERISTICS ^b						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250µA	1	1.5	3	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 6.6A		18	25	m ohm
		V _{GS} = 4.5V, I _D = 5A		32	40	m ohm
On-State Drain Current	I _{D(ON)}	V _{DS} = 5V, V _{GS} = 4.5V	20			A
Forward Transconductance	g _F	V _{DS} = 5V, I _D = 6.6A		9		S
DYNAMIC CHARACTERISTICS ^c						
Input Capacitance	C _{ISS}	V _{DS} = 15V, V _{GS} = 0V f = 1.0MHz		630	745	pF
Output Capacitance	C _{OSS}			170	200	pF
Reverse Transfer Capacitance	C _{RSS}			105	125	pF
Gate resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1.0MHz		3.5		ohm
SWITCHING CHARACTERISTICS ^c						
Turn-On Delay Time	t _{D(ON)}	V _{DD} = 15V I _D = 6.6 A V _{GS} = 10V R _{GEN} = 3 ohm		15.2	18	ns
Rise Time	t _r			5.3	6	ns
Turn-Off Delay Time	t _{D(OFF)}			22.1	26	ns
Fall Time	t _f			12.8	15	ns
Total Gate Charge	Q _g	V _{DS} = 15V, I _D = 6.6A, V _{GS} = 10V		13.3	15	nC
		V _{DS} = 15V, I _D = 6.6A, V _{GS} = 4.5V		7.2	8	nC
Gate-Source Charge	Q _{gs}	V _{DS} = 15V, I _D = 6.6 A V _{GS} = 10V		2.9	3.4	nC
				3.6	4.2	nC

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P-Channel ELECTRICAL CHARACTERISTICS (TA = 25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = -250µA	-30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -24V, V _{GS} = 0V		-1		µA
Gate-Body Leakage	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V		±100		nA
ON CHARACTERISTICS ^b						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250µA	-1	-1.5	-3	V
Drain-Source On-State Resistance	R _{DSON}	V _{GS} = -10V, I _D = -5A		35	45	m ohm
		V _{GS} = -4.5V, I _D = -4A		48	60	m ohm
On-State Drain Current	I _{D(ON)}	V _{DS} = -5V, V _{GS} = -10V	-12			A
Forward Transconductance	g _F	V _{DS} = -5V, I _D = -5A		9		S
DYNAMIC CHARACTERISTICS ^c						
Input Capacitance	C _{ISS}	V _{DS} = -15V, V _{GS} = 0V f = 1.0MHz		770	885	pF
Output Capacitance	C _{OSS}			180	205	pF
Reverse Transfer Capacitance	C _{RSS}			110	133	pF
Gate resistance	R _G	V _{GS} = 0V, V _{DS} = 0V, f = 1.0MHz		3.3		ohm
SWITCHING CHARACTERISTICS ^c						
Turn-On Delay Time	t _{D(ON)}	V _{DD} = -15V R _L = 3 ohm V _{GS} = -10V R _{GEN} = 3 ohm		12.6	15	ns
Rise Time	t _r			9.6	11	ns
Turn-Off Delay Time	t _{D(OFF)}			49.5	56	ns
Fall Time	t _f			27.8	32	ns
Total Gate Charge	Q _G	V _{DS} = -15V, I _D = -5A, V _{GS} = -10V		14	16	nC
		V _{DS} = -15V, I _D = -5A, V _{GS} = -4.5V		7.2	8	nC
Gate-Source Charge	Q _{GS}	V _{DS} = -15V, I _D = -5 A V _{GS} = -10V		2.3	2.7	nC
Gate-Drain Charge	Q _{GD}			3.2	3.8	nC

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ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS ^b						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0V, I_S = 1.7A$ $V_{GS} = 0V, I_S = -1.7A$	N-Ch P-Ch		0.8 -0.8	1.2 -1.2

Notes

a. Surface Mounted on FR4 Board, $t \leq 10\text{sec}$.

* $R_{\theta JA}$ is $62.5^\circ\text{C}/\text{W}$ when mounted on 1in^2 FR-4 board with 2oz Copper

* $R_{\theta JA}$ is $125^\circ\text{C}/\text{W}$ when mounted on 0.02 in^2 FR-4 board with 2oz Copper

b. Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2\%$.

c. Guaranteed by design, not subject to production testing.

N-Channel

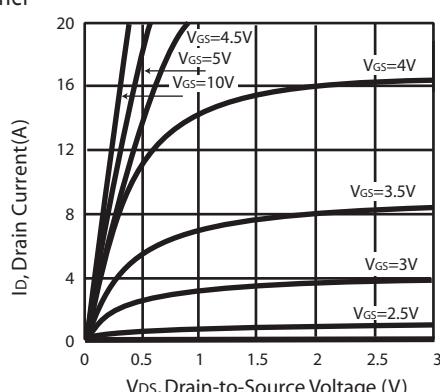


Figure 1. Output Characteristics

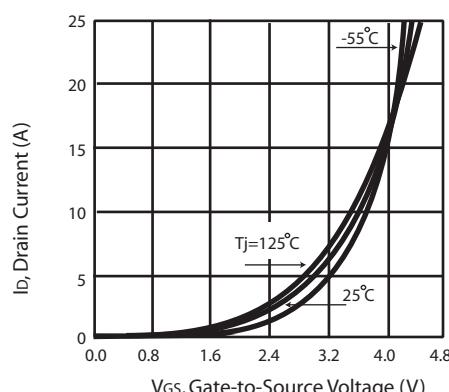


Figure 2. Transfer Characteristics

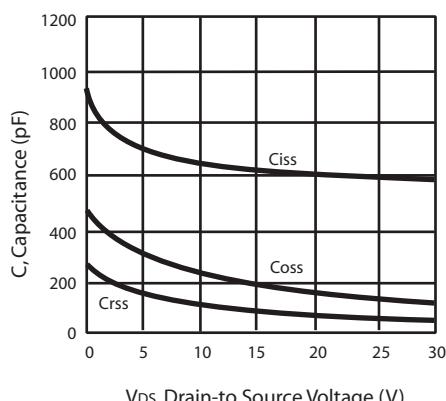


Figure 3. Capacitance

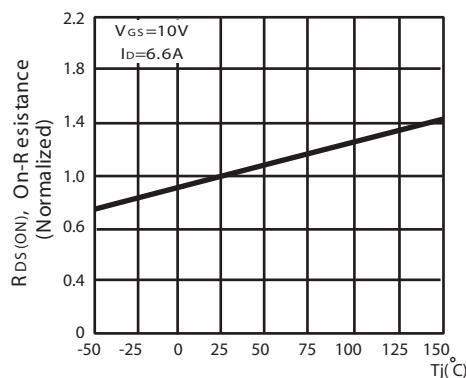


Figure 4. On-Resistance Variation with Drain Current and Temperature

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N-Channel

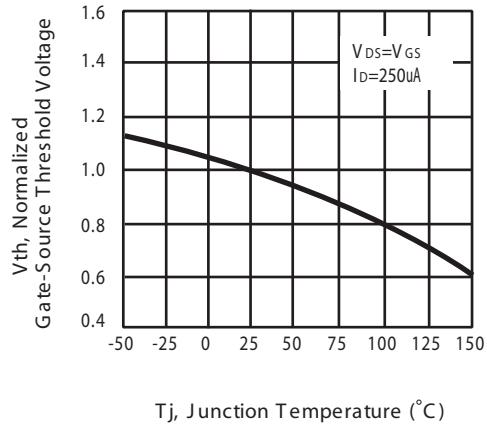


Figure 5. Gate Threshold Variation with Temperature

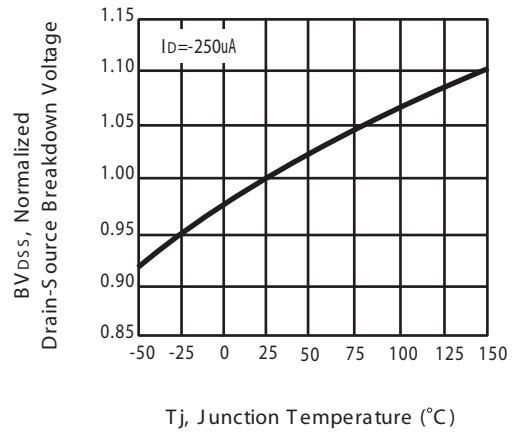


Figure 6. Breakdown Voltage Variation with Temperature

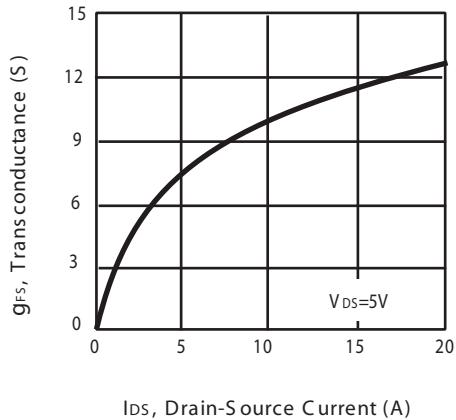


Figure 7. Transconductance Variation with Drain Current

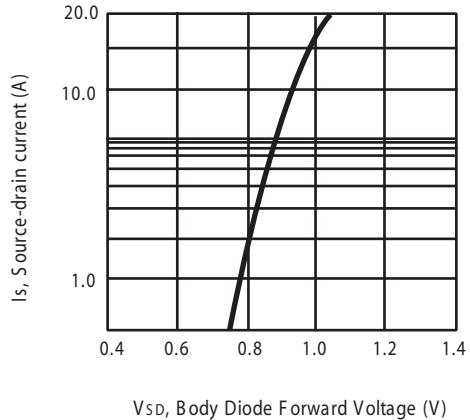


Figure 8. Body Diode Forward Voltage Variation with Source Current

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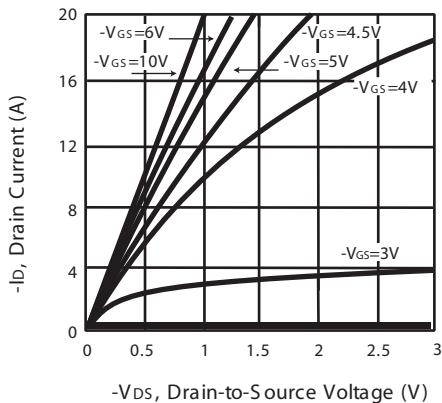


Figure 1. Output Characteristics

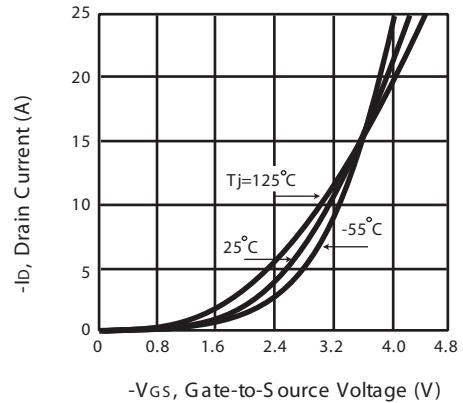


Figure 2. Transfer Characteristics

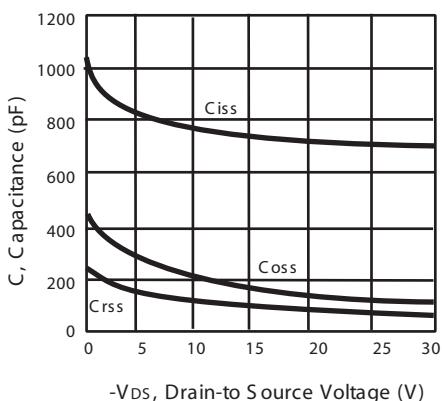


Figure 3. Capacitance

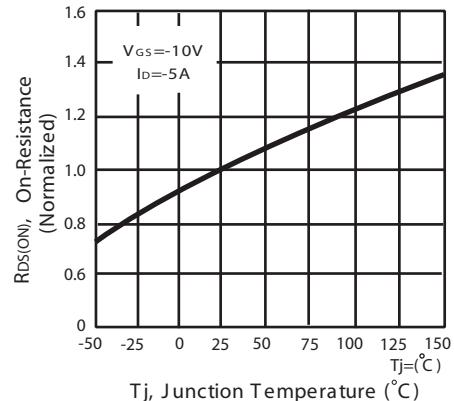


Figure 4. On-Resistance Variation with Temperature

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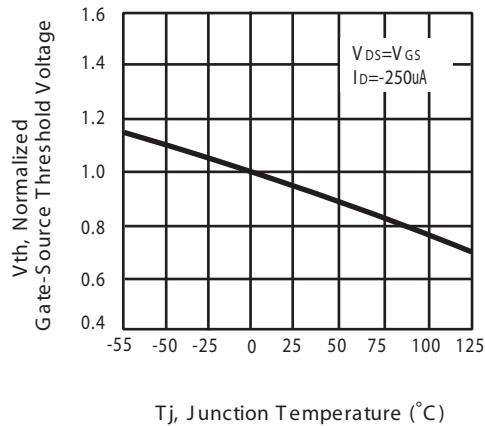


Figure 5. Gate Threshold Variation with Temperature

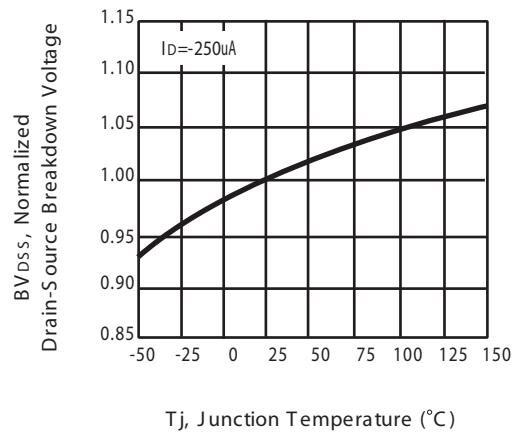


Figure 6. Breakdown Voltage Variation with Temperature

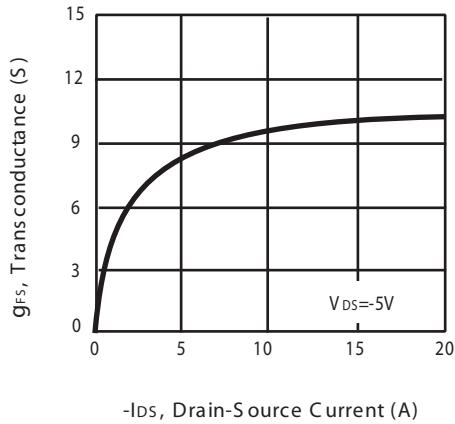


Figure 7. Transconductance Variation with Drain Current

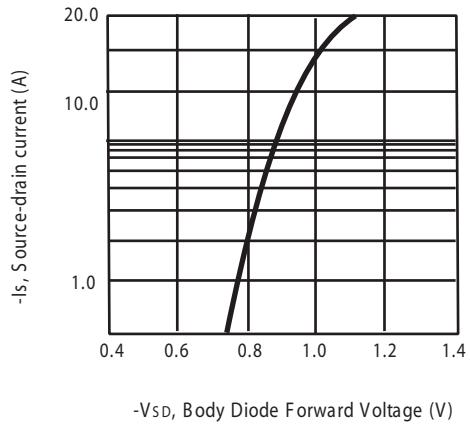
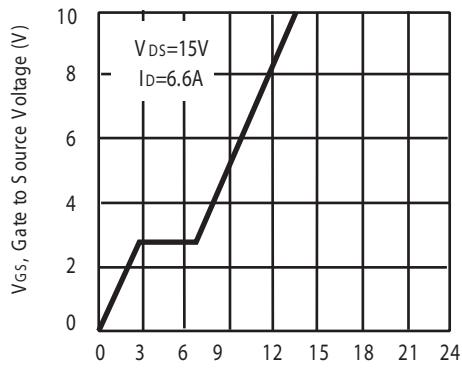


Figure 8. Body Diode Forward Voltage Variation with Source Current

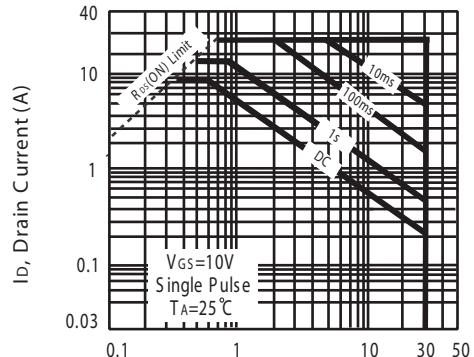
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N-Channel



$V_{DS}=15V$
 $I_D=6.6A$

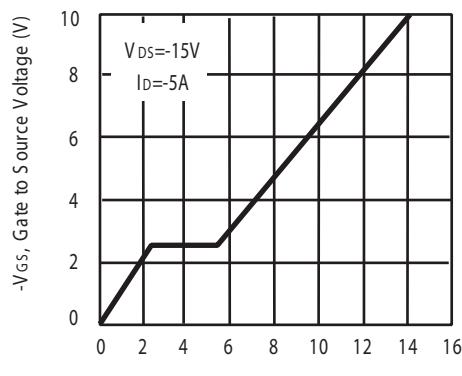
Figure 9. Gate Charge



$V_{GS}=10V$
Single Pulse
 $T_A=25^\circ C$

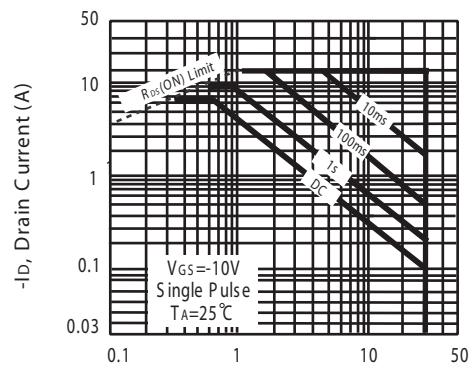
Figure 10. Maximum Safe Operating Area

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$V_{DS}=-15V$
 $I_D=5A$

Figure 9. Gate Charge



$V_{GS}=-10V$
Single Pulse
 $T_A=25^\circ C$

Figure 10. Maximum Safe Operating Area

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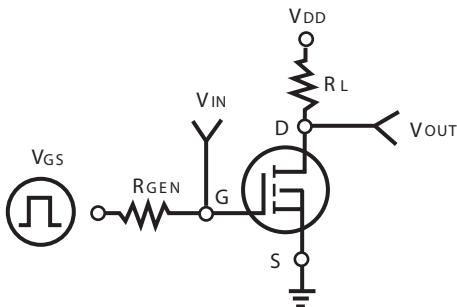


Figure 11. Switching Test Circuit

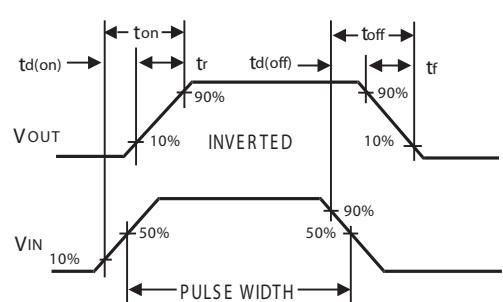
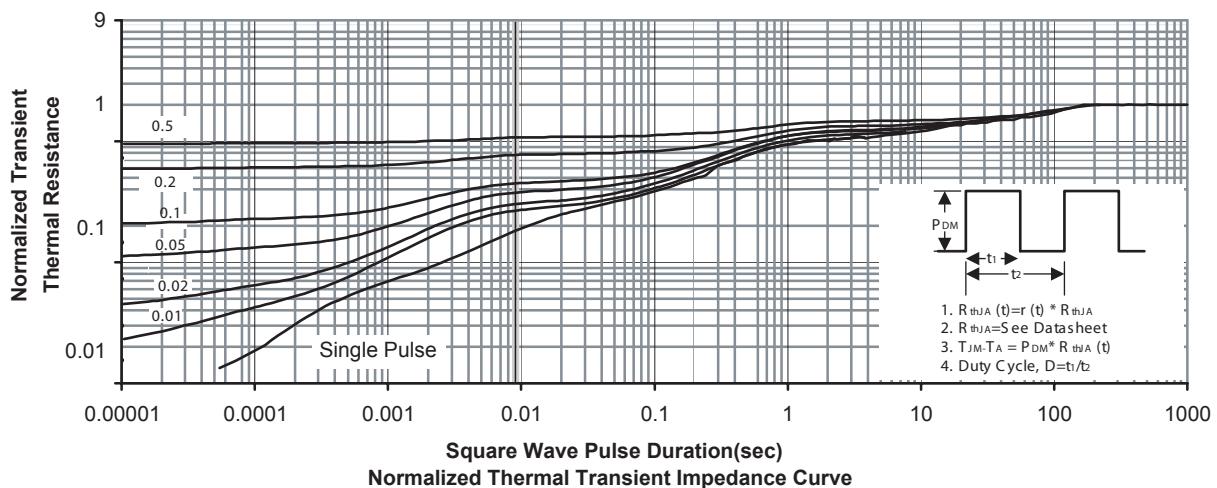
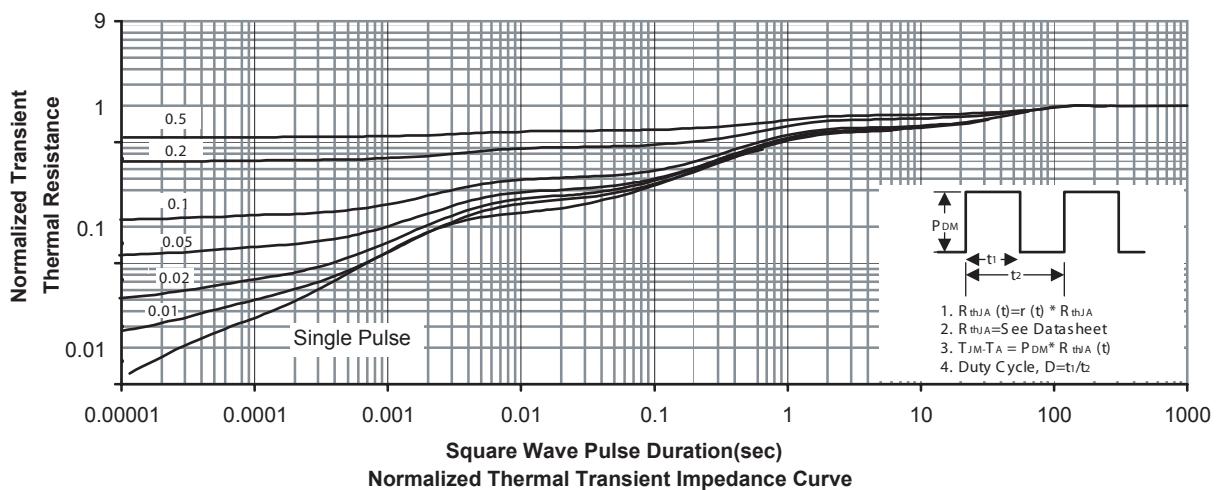


Figure 12. Switching Waveforms

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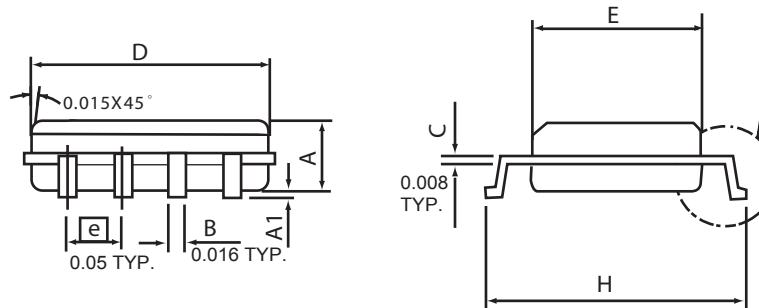
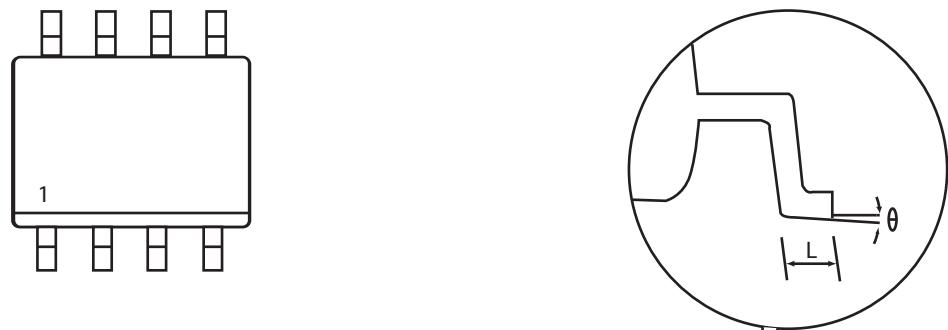
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PACKAGE OUTLINE DIMENSIONS

SO-8

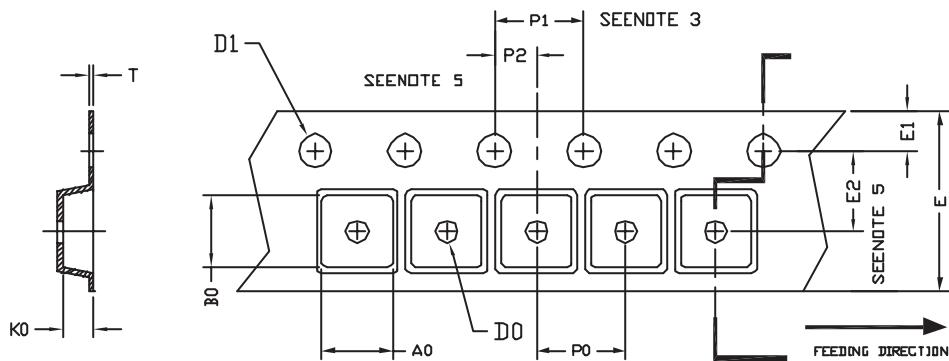


SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
D	4.80	4.98	0.189	0.196
E	3.81	3.99	0.150	0.157
H	5.79	6.20	0.228	0.244
L	0.41	1.27	0.016	0.050
θ	0°	8°	0°	8°

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SO-8 Tape and Reel Data

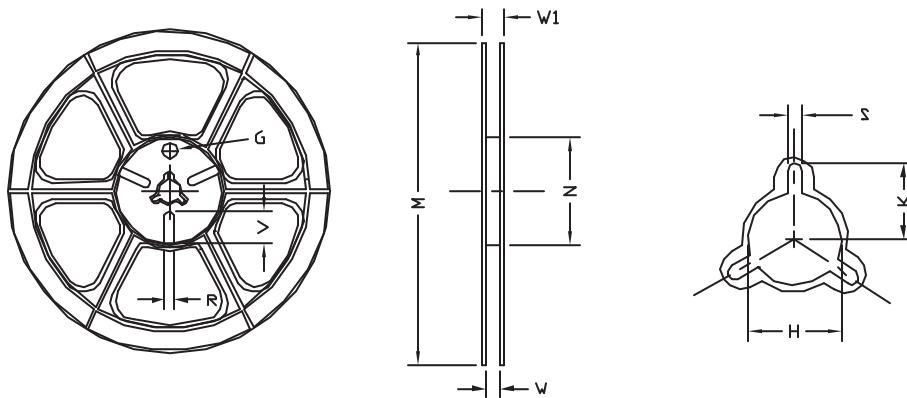
SO-8 Carrier Tape



unit:mm

PACKAGE	A0	B0	K0	D0	D1	E	E1	E2	P0	P1	P2	T
SOP 8N 150mil	6.40	5.20	2.10	$\phi 1.5$ (MIN)	$\phi 1.5$ $+ 0.1$ $- 0.0$	12.0 ± 0.3	1.75	5.5 ± 0.05	8.0	4.0	2.0 ± 0.05	0.3 ± 0.05

SO-8 Reel



UNIT:mm

TAPE SIZE	REEL SIZE	M	N	W	W1	H	K	S	G	R	V
12 mm	$\phi 330$	330 ± 1	62 ± 1.5	12.4 $+ 0.2$	16.8 $- 0.4$	$\phi 12.75$ $+ 0.15$	---	2.0 ± 0.15	---	---	---